

# FCP13N60N / FCPF13N60NT

## N-Channel SupreMOS® MOSFET

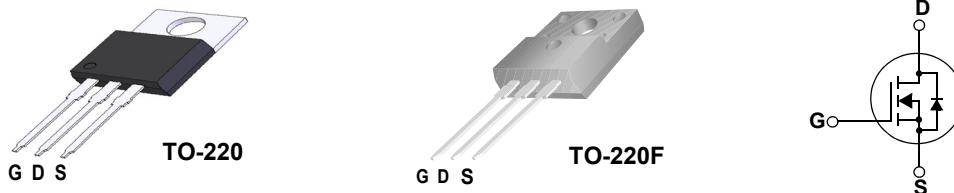
### 600 V, 13 A, 258 mΩ

#### Features

- $R_{DS(on)} = 244 \text{ m}\Omega$  (Typ.) @  $V_{GS} = 10 \text{ V}$ ,  $I_D = 6.5 \text{ A}$
- Ultra Low Gate Charge (Typ.  $Q_g = 30.4 \text{ nC}$ )
- Low Effective Output Capacitance (Typ.  $C_{oss,eff} = 145 \text{ pF}$ )
- 100% Avalanche Tested
- RoHS Compliant

#### Application

- LCD/LED/PDP TV
- Lighting
- Solar Inverter
- AC-DC Power Supply



#### MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	FCP13N60N	FCPF13N60NT	Unit
$V_{DSS}$	Drain to Source Voltage	600		V
$V_{GSS}$	Gate to Source Voltage		$\pm 30$	V
$I_D$	Drain Current	13	13*	A
	-Continuous ( $T_C = 25^\circ\text{C}$ )	8.2	8.2*	
$I_{DM}$	Drain Current	(Note 1)	39	A
$E_{AS}$	Single Pulsed Avalanche Energy	(Note 2)	235	mJ
$I_{AR}$	Avalanche Current		4.3	A
$E_{AR}$	Repetitive Avalanche Energy		1.16	mJ
$dv/dt$	MOSFET $dv/dt$ Ruggedness		100	V/ns
	Peak Diode Recovery $dv/dt$	(Note 3)	20	V/ns
$P_D$	Power Dissipation	( $T_C = 25^\circ\text{C}$ )	116	W
	- Derate above $25^\circ\text{C}$	0.93	0.27	W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
$T_L$	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	$^\circ\text{C}$

\*Drain current limited by maximum junction temperature

#### Thermal Characteristics

Symbol	Parameter	FCP13N60N	FCPF13N60NT	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.07	3.7	$^\circ\text{C}/\text{W}$
$R_{\theta CS}$	Thermal Resistance, Case to Heak Sink ( Typical)	0.5	0.5	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FCP13N60N	FCP13N60N	TO-220	-	-	50
FCPF13N60NT	FCPF13N60NT	TO-220F	-	-	50

## Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
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### Off Characteristics

$\text{BV}_{\text{DSS}}$	Drain to Source Breakdown Voltage	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}, T_C = 25^\circ\text{C}$	600	-	-	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 1 \text{ mA}, \text{Referenced to } 25^\circ\text{C}$	-	0.73	-	$\text{V}/^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	10	$\mu\text{A}$
		$V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}, T_C = 125^\circ\text{C}$	-	-	100	
$I_{\text{GSS}}$	Gate to Body Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	$\pm 100$	nA

### On Characteristics

$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$	2.0	-	4.0	V
$R_{DS(\text{on})}$	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}$	-	0.220	0.258	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 40 \text{ V}, I_D = 6.5 \text{ A}$	-	16.3	-	S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$	-	1325	1765	pF
$C_{oss}$	Output Capacitance	$f = 1 \text{ MHz}$	-	50	65	pF
$C_{rss}$	Reverse Transfer Capacitance		-	3	5	pF
$C_{oss}$	Output Capacitance	$V_{DS} = 380 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	30	-	pF
$C_{oss,eff}$	Effective Output Capacitance	$V_{DS} = 0 \text{ V to } 480 \text{ V}, V_{GS} = 0 \text{ V}$	-	145	-	pF
$Q_g(\text{tot})$	Total Gate Charge at 10V	$V_{DS} = 380 \text{ V}, I_D = 6.5 \text{ A}$	-	30.4	39.5	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{GS} = 10 \text{ V}$	(Note 4)	6.0	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge			9.5	-	nC
ESR	Equivalent Series Resistance (G-S)	Drain Open	-	2.8	-	$\Omega$

### Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 380 \text{ V}, I_D = 6.5 \text{ A}$	-	14.5	39	ns
$t_r$	Turn-On Rise Time	$R_G = 4.7 \Omega$	-	10.6	31.2	ns
$t_{d(off)}$	Turn-Off Delay Time		-	45	100	ns
$t_f$	Turn-Off Fall Time		(Note 4)	9.8	29.6	ns

### Drain-Source Diode Characteristics

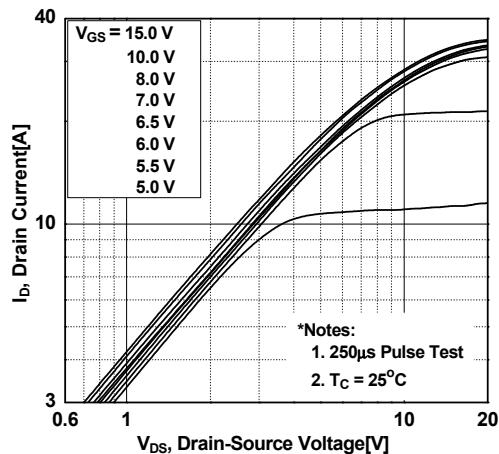
$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	13	A
$I_{SM}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	39	A
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{SD} = 6.5 \text{ A}$	-	-	1.2
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{SD} = 6.5 \text{ A}$	-	287	-
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	3.5	$\mu\text{C}$

#### Notes:

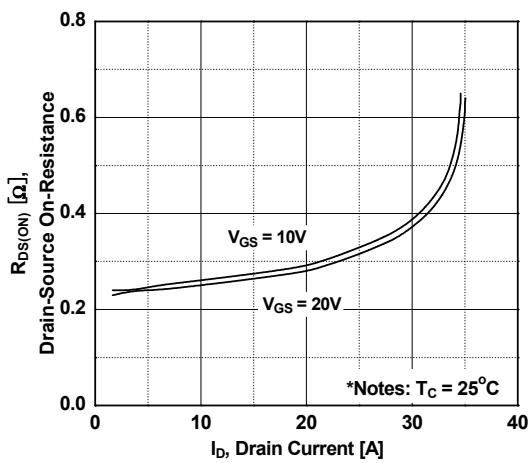
1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $I_{AS} = 4.3 \text{ A}, R_G = 25 \Omega, \text{Starting } T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 13 \text{ A}, di/dt \leq 200 \text{ A}/\mu\text{s}, V_{DD} \leq \text{BV}_{\text{DSS}}, \text{Starting } T_J = 25^\circ\text{C}$
4. Essentially Independent of Operating Temperature Typical Characteristics

## Typical Performance Characteristics

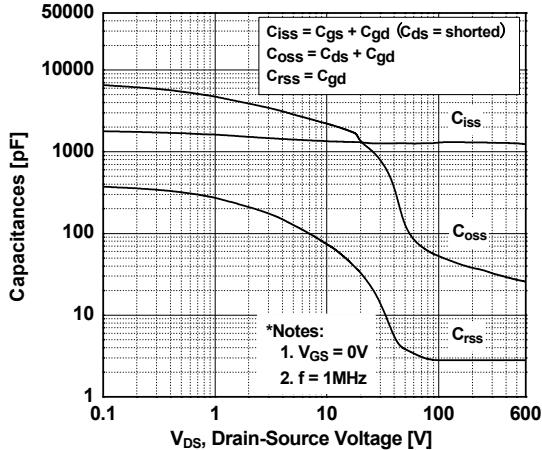
**Figure 1. On-Region Characteristics**



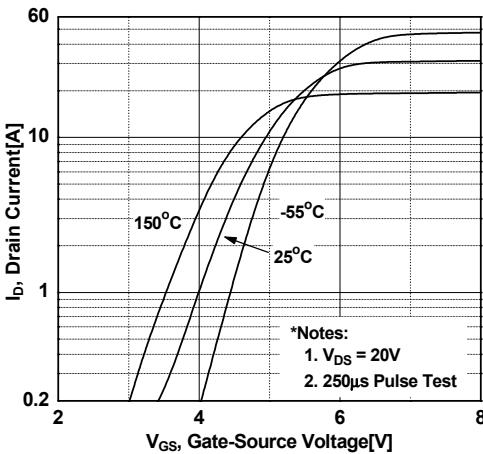
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



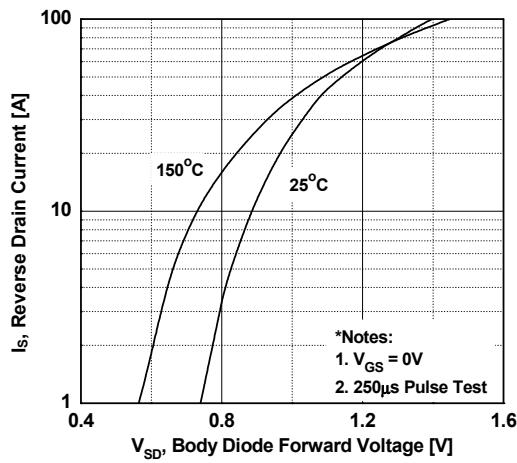
**Figure 5. Capacitance Characteristics**



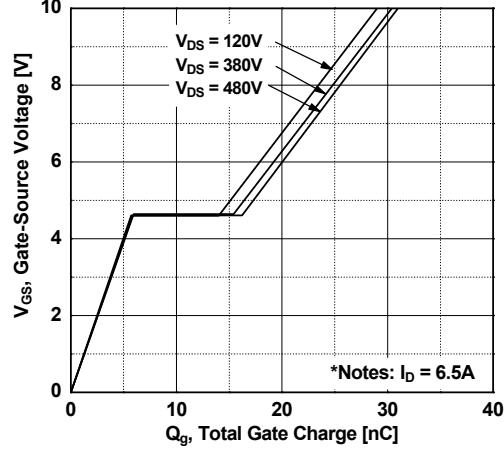
**Figure 2. Transfer Characteristics**



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

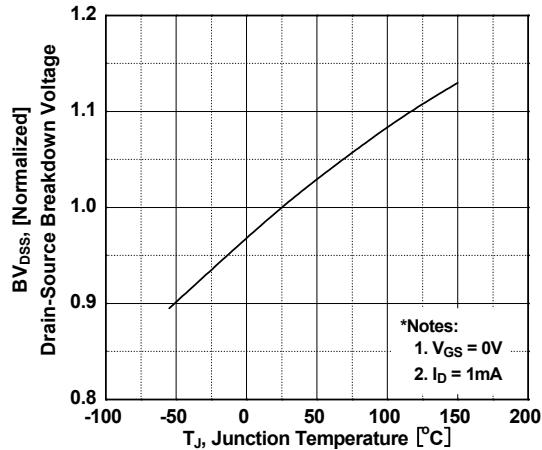


**Figure 6. Gate Charge Characteristics**

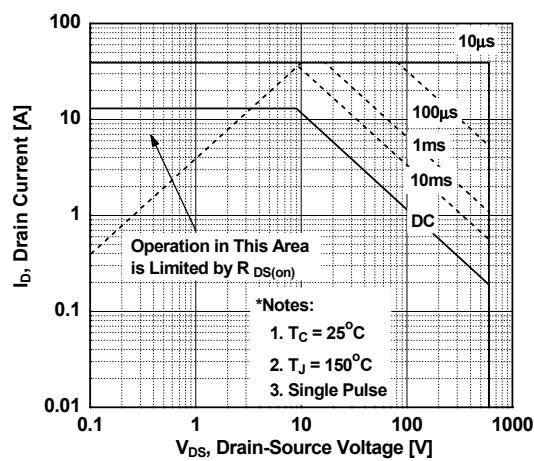


## Typical Performance Characteristics (Continued)

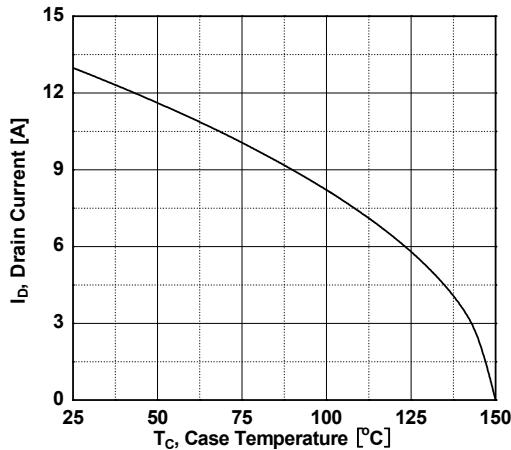
**Figure 7. Breakdown Voltage Variation vs. Temperature**



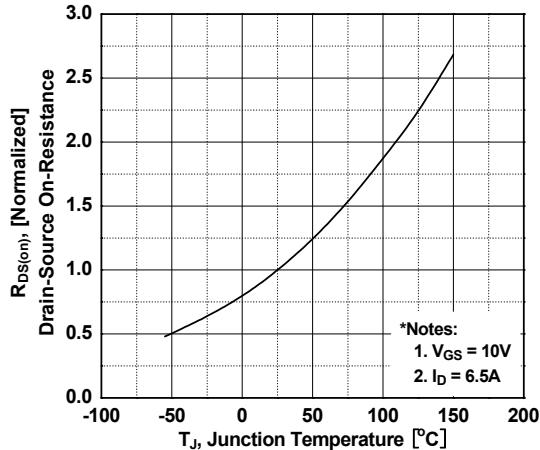
**Figure 9. Maximum Safe Operating Area – FCP13N60N**



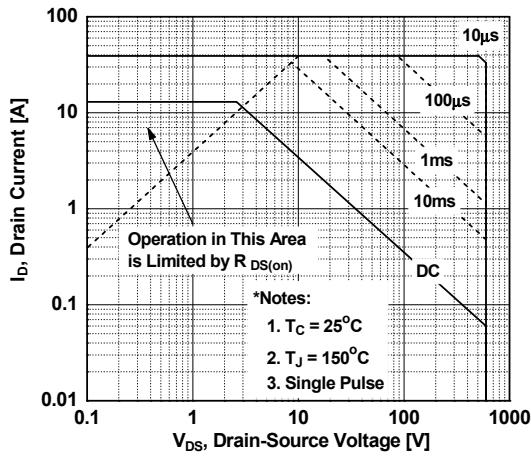
**Figure 11. Maximum Drain Current vs. Case Temperature**



**Figure 8. On-Resistance Variation vs. Temperature**



**Figure 10. Maximum Safe Operating Area – FCPF13N60NT**



## Typical Performance Characteristics (Continued)

Figure 12. Transient Thermal Response Curve \_ FCP13N60N

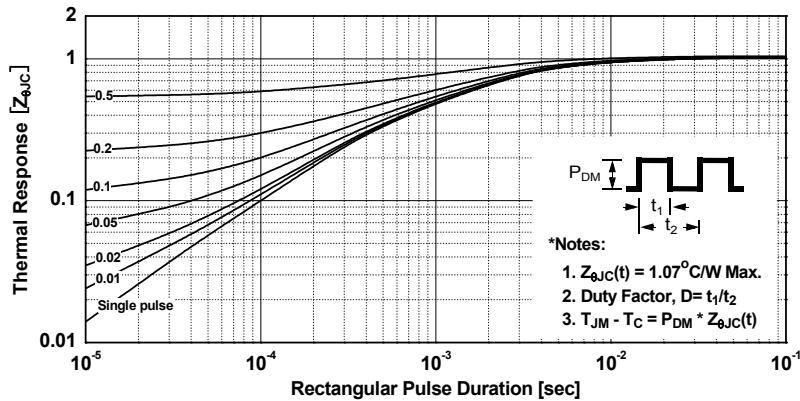
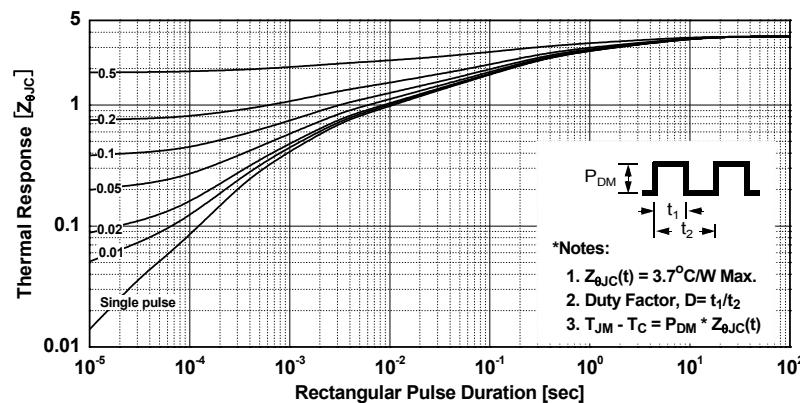
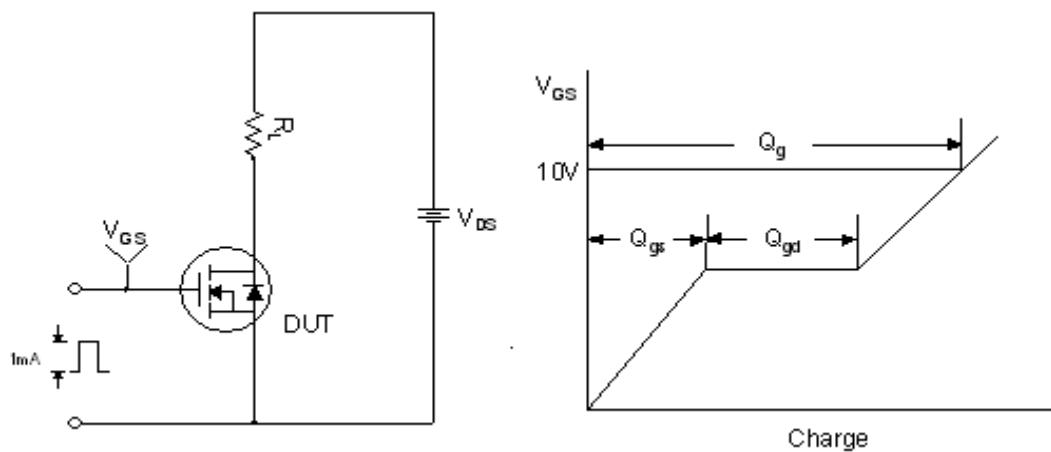


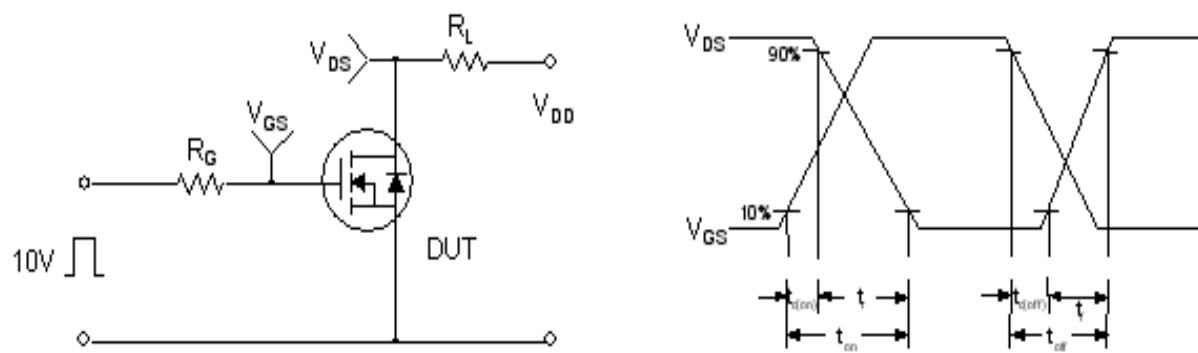
Figure 13. Transient Thermal Response Curve \_ FCPF13N60NT



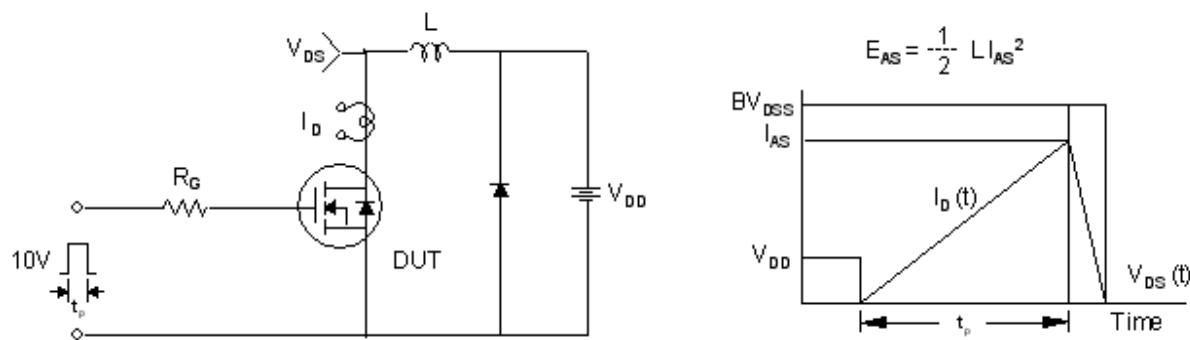
Gate Charge Test Circuit & Waveform



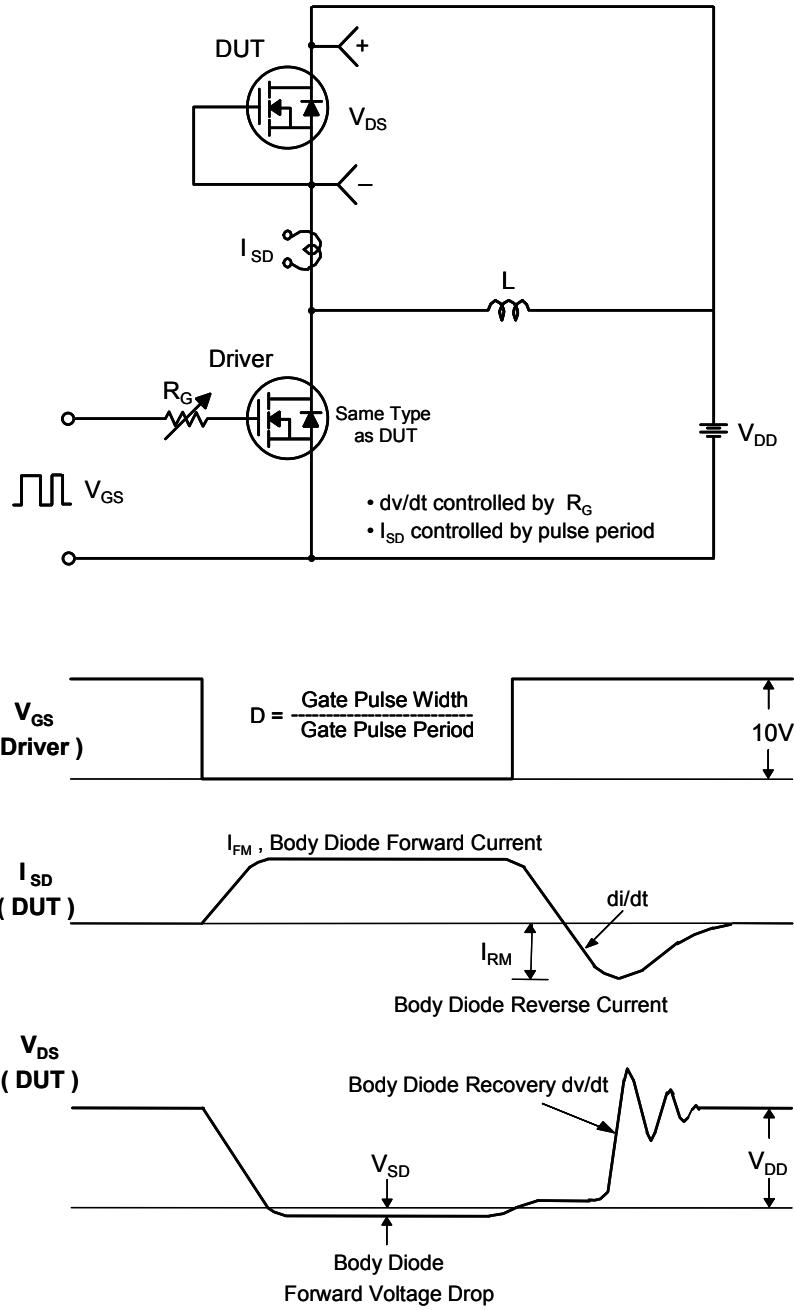
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

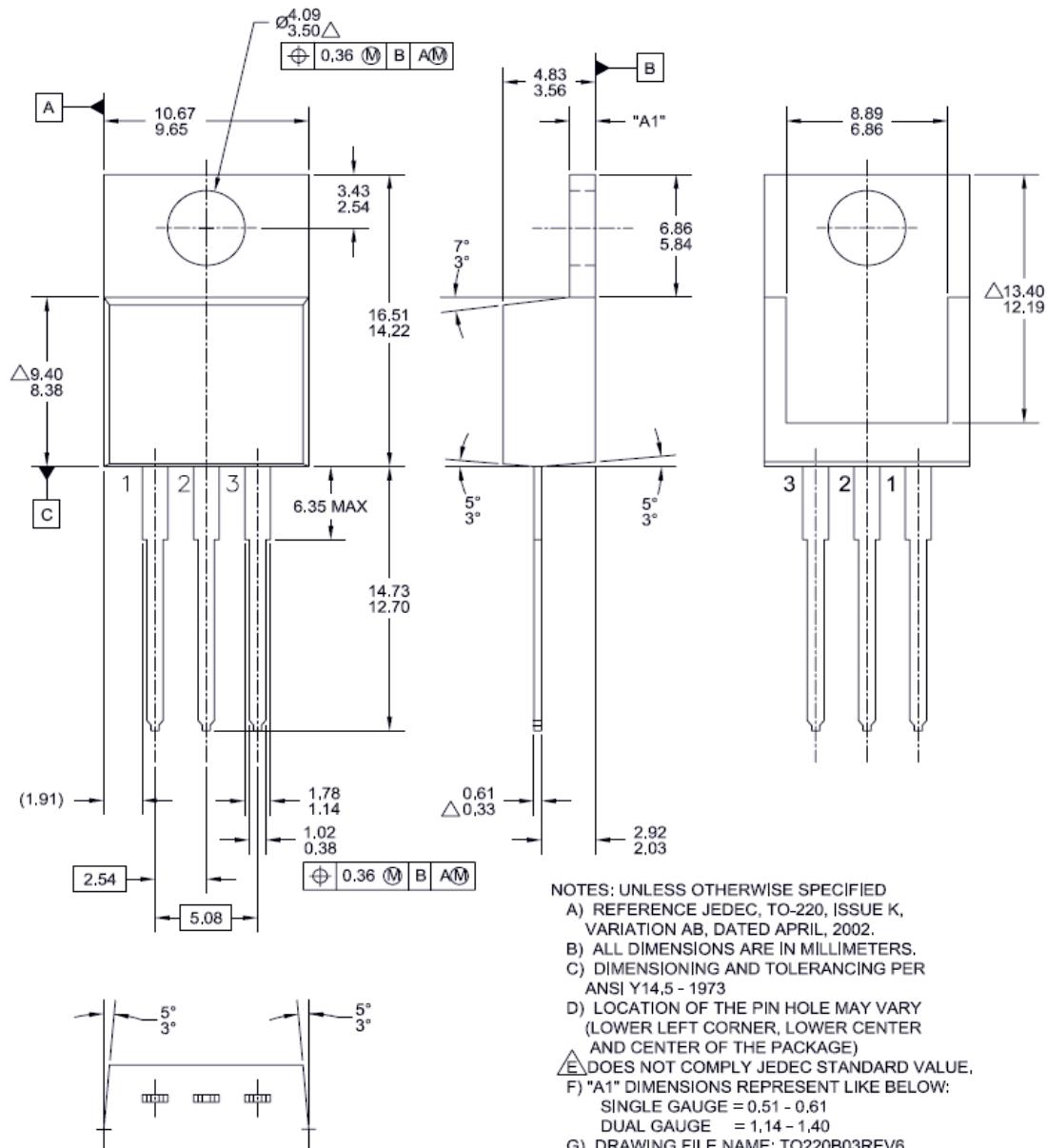


## Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms

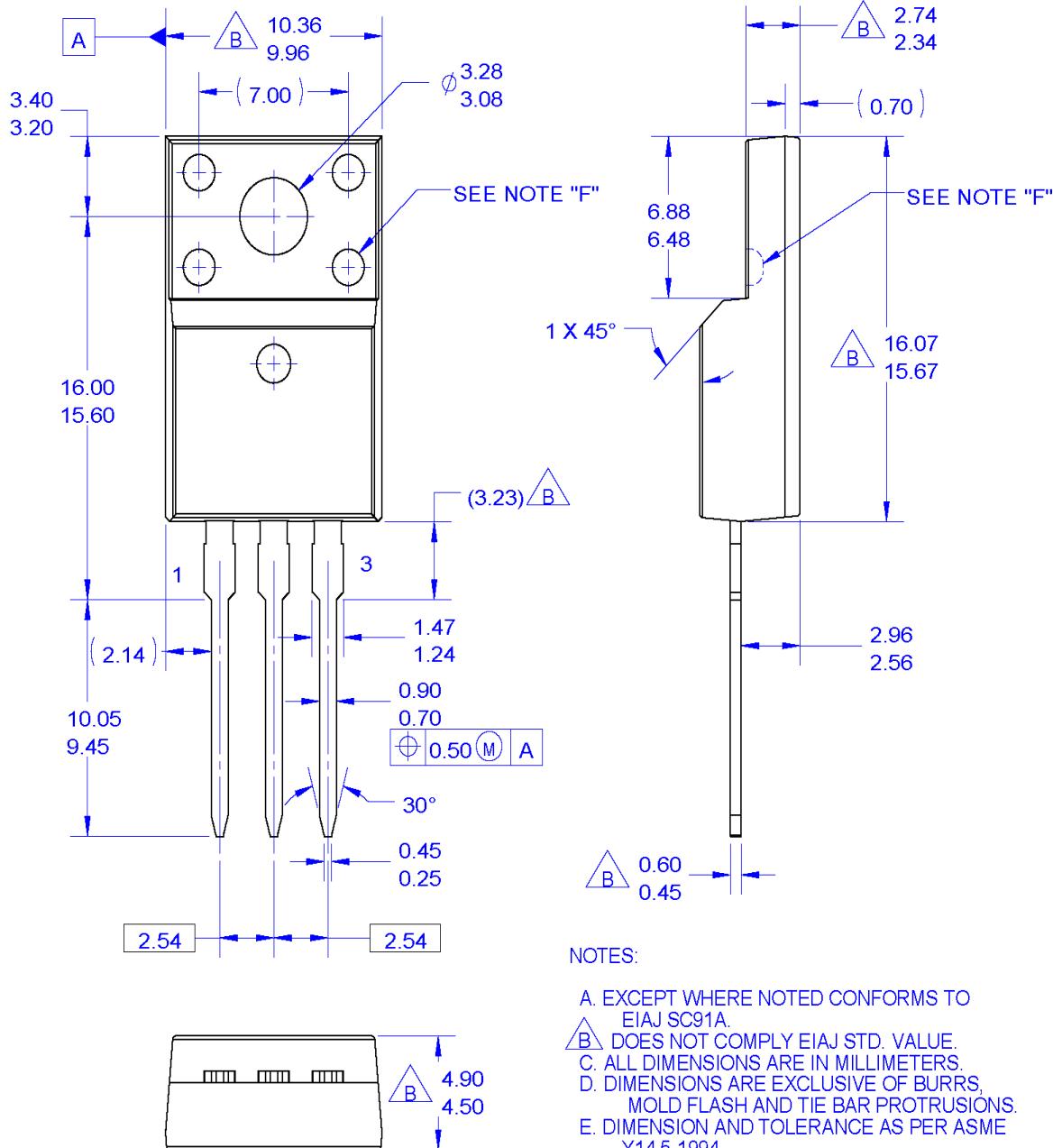


## Mechanical Dimensions

TO-220



Dimensions in Millimeters

**Mechanical Dimensions****TO-220F**

Dimensions in Millimeters



#### TRADEMARKS

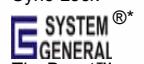
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